

Notice of References Cited	Application/Control No. 10/510,224		Applicant(s)/Patent Under Reexamination SCHAETZER ET AL.	
	Examiner Helen Mei-Ping Chui		Art Unit 1616	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,849,578	02-2005	Wellmann et al.	504/130
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	WO 02/28182	04-2002	PCT	Schaetzer et al.	A01N 43/40
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Davies, J. (Pesticide Outlook, 2001: February, 10-15).
	V	
	W	
	X	

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Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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